# SN54HCT574, SN74HCT574 OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

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- Operating Voltage Range of 4.5 V to 5.5 V
- High-Current 3-State Noninverting Outputs Drive Bus Lines Directly or Up To 15 LSTTL Loads
- Low Power Consumption, 80-μA Max I<sub>CC</sub>
- Typical t<sub>pd</sub> = 22 ns
- ±6-mA Output Drive at 5 V
- Low Input Current of 1 μA Max
- Inputs Are TTL-Voltage Compatible
- Bus-Structured Pinout

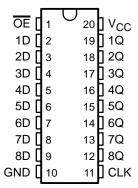
#### description/ordering information

These octal edge-triggered D-type flip-flops feature 3-state outputs designed specifically for bus driving. The 'HCT574 devices are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

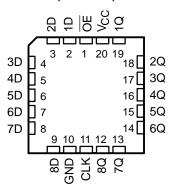
The eight flip-flops enter data on the low-to-high transition of the clock (CLK) input.

A buffered output-enable  $(\overline{OE})$  input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

SN54HCT574 . . . J OR W PACKAGE SN74HCT574 . . . DB, DW, N, NS, OR PW PACKAGE (TOP VIEW)



SN54HCT574 . . . FK PACKAGE (TOP VIEW)



 $\overline{\text{OE}}$  does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

#### **ORDERING INFORMATION**

TA	PACKA	<sub>GE</sub> †	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	PDIP – N	Tube SN74HCT574N		SN74HCT574N	
	0010 014	Tube	SN74HCT574DW	LIOTEZA	
	SOIC – DW	Tape and reel	SN74HCT574DWR	HCT574	
-40°C to 85°C	SOP - NS	Tape and reel	SN74HCT574NSR	HCT574	
	SSOP - DB	Tape and reel	SN74HCT574DBR	HT574	
	TOOOD DW	Tube	SN74HCT574PW	LITEZA	
	TSSOP – PW	Tape and reel	SN74HCT574PWR	HT574	
	CDIP – J	Tube	SNJ54HCT574J	SNJ54HCT574J	
–55°C to 125°C	CFP – W	Tube	SNJ54HCT574W	SNJ54HCT574W	
	LCCC – FK	Tube	SNJ54HCT574FK	SNJ54HCT574FK	

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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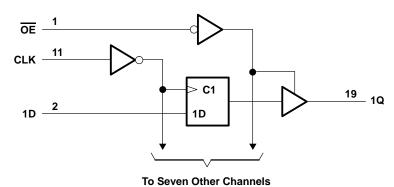


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### FUNCTION TABLE (each flip-flop)

	INPUTS	OUTPUT	
ŌĒ	CLK	D	Q
L	1	Н	Н
L	$\uparrow$	L	L
L	H or L	Χ	$Q_0$
Н	Х	Χ	Z

### logic diagram (positive logic)



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) (see Note 1)	±20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) (see Note 1)	±20 mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )	±35 mA
Continuous current through V <sub>CC</sub> or GND	±70 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): DB package	70°C/W
DW package	58°C/W
N package	69°C/W
NS package	60°C/W
PW package	83°C/W
Storage temperature range, T <sub>stq</sub>	65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



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### recommended operating conditions (see Note 3)

			SN54HCT574			SN	74HCT5	74	
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2	S		2			V
VIL	Low-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V		Of The	0.8			0.8	V
٧ <sub>I</sub>	Input voltage		0	70	Vcc	0		Vcc	V
٧o	Output voltage		0 <	20	Vcc	0		Vcc	V
Δt/Δν	Input transition rise/fall time		200		500			500	ns
TA	Operating free-air temperature		-55	•	125	-40	•	85	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS		.,	Т	A = 25°C	;	SN54HCT574		SN74HCT574		
PARAMETER	TEST CO	vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
	Mr. Mr. an Mr.	I <sub>OH</sub> = -20 μA	45.1/	4.4	4.499		4.4		4.4		V
Voн	$V_I = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		V
., .,		$I_{OL} = 20 \mu A$	45.17		0.001	0.1		0.1		0.1	
VOL	$V_I = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 6 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	<b>V</b>
lį	$V_I = V_{CC}$ or 0		5.5 V		±0.1	±100		±1000		±1000	nA
loz	$V_O = V_{CC}$ or 0		5.5 V		±0.01	±0.5	4	±10		±5	μΑ
ICC	$V_I = V_{CC}$ or 0,	IO = 0	5.5 V			8	2	160		80	μΑ
ΔI <sub>CC</sub> †	One input at 0.5 V Other inputs at 0 o		5.5 V		1.4	2.4	PRO,	3		2.9	mA
C <sub>i</sub>			4.5 V to 5.5 V		3	10		10		10	pF

<sup>†</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

### timing requirements over recommended operating free-air temperature range (unless otherwise noted)

				25°C	SN54H	CT574	SN74H	CT574	TUALIT
		vcc	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
,	Clock frequency	4.5 V		30		20		24	
fclock		5.5 V		33		22		27	MHz
		4.5 V	16		24	F	20		
t <sub>W</sub>	Pulse duration, CLK high or low	5.5 V	14		22 (	Q.	18		ns
		4.5 V	20		30		25		
t <sub>su</sub>	Setup time, data before CLK↑	5.5 V	17		27		23		ns
4.	Hold time, data after CLK↑	4.5 V	5		5		5		ns
th		5.5 V	5		5		5		

### SN54HCT574, SN74HCT574 OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

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### switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

242445	FROM	то		T	չ = 25°C	;	SN54H	CT574	SN74H	CT574	
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	MIN TYP MAX		MIN	MAX	MIN	MAX	UNIT
			4.5 V	30	36		20		24		N41.1-
f <sub>max</sub>			5.5 V	33	40		22		27		MHz
4 .	CL K	A O	4.5 V		30	36		54		45	
<sup>t</sup> pd	CLK	Any Q	5.5 V		25	32		48		41	ns
	ŌĒ	A O	4.5 V		26	30	. 4	45		38	
t <sub>en</sub>	OE	Any Q	5.5 V		23	27	(2)	41		34	ns
	ŌĒ	A O	4.5 V		23	30	200	45		38	
<sup>t</sup> dis	OE	Any Q	5.5 V		22	27	4	41		34	ns
4.		Δην. Ο	4.5 V		10	12		18		15	20
t <sub>t</sub>		Any Q	5.5 V		9	11		16		14	ns

## switching characteristics over recommended operating free-air temperature range, $C_L$ = 150 pF (unless otherwise noted) (see Figure 1)

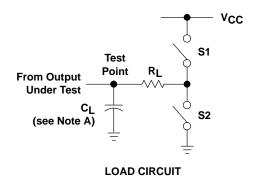
242445	FROM TO		FROM TO		l .,	T <sub>A</sub> = 25°C		SN54HCT574		SN74HCT574		
PARAMETER	(INPUT)	(OUTPUT)	vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
,			4.5 V	30	36		20		24		N 41 1-	
fmax			5.5 V	33	40		22	JA)	27		MHz	
	01.14	OLK		4.5 V		40	53		80		66	
<sup>t</sup> pd	CLK	Any Q	5.5 V		35	47	_ <	71		60	ns	
	<u>OE</u>	A O	4.5 V		34	47	, '0,	71		59		
<sup>t</sup> en	OE	Any Q	5.5 V		29	39	<sup>l</sup> q <sub>C</sub>	94		78	ns	
4.		Any O	4.5 V		18	42	Q'	63		53	ns	
t <sub>t</sub>		Any Q	5.5 V	·	16	38		57		48	115	

### operating characteristics, T<sub>A</sub> = 25°C

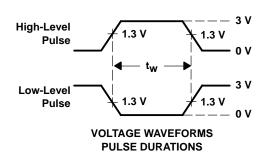
	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance per flip-flop	No load	93	pF

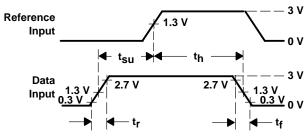
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#### PARAMETER MEASUREMENT INFORMATION

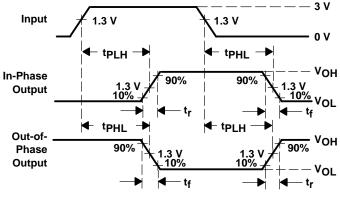


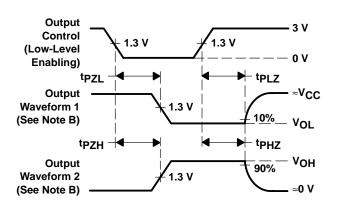
PARA	VIETER	RL	CL	S1	S2	
	t <sub>PZH</sub> 50 pF 1 kΩ or		Open	Closed		
<sup>t</sup> en	tPZL	1 K22	or 150 pF	Closed	Open	
4	tPHZ	<b>1 k</b> Ω	50 pF	Open	Closed	
<sup>t</sup> dis	tPLZ	1 K22	50 pr	Closed	Open	
t <sub>pd</sub> or	t <sub>pd</sub> or t <sub>t</sub> — o		50 pF or 150 pF	Open	Open	





VOLTAGE WAVEFORMS
SETUP AND HOLD AND INPUT RISE AND FALL TIMES





VOLTAGE WAVEFORMS
PROPAGATION DELAY AND OUTPUT RISE AND FALL TIMES

VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS

NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> = 6 ns.
- D. For clock inputs,  $f_{\text{max}}$  is measured when the input duty cycle is 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. tpLz and tpHz are the same as tdis.
- G. tp7I and tp7H are the same as ten.
- H. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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Mailing Address:

Texas Instruments Post Office Box 655303 Dallas, Texas 75265

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